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20-V N-Channel NexFET™ Power MOSFETs

Check for Samples: CSD15571Q2

FEATURES

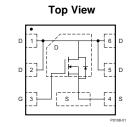
- Ultralow Q_g and Q_{gd}
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- RoHS Compliant
- Halogen Free
- SON 2-mm × 2-mm Plastic Package

APPLICATIONS

- Optimized for Load Switch Applications
- Storage, Tablets, and Handheld Devices
- Optimized for Control FET Applications
- Point of Load Synchronous Buck Converters

DESCRIPTION

The NexFET[™] power MOSFET has been designed to minimize losses in power conversion and load management applications. The SON 2x2 offers excellent thermal performance for the size of the package.



PRODUCT SUMMARY

V _{DS}	Drain to Source Voltage	20	V		
Qg	Gate Charge Total (4.5V) 2.5				
Q _{gd}	Gate Charge Gate to Drain	0.66	nC		
D	Drain to Source On Resistance	$V_{GS} = 4.5V$	16	mΩ	
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V$	12	mΩ	
V _{GS(th)}	Threshold Voltage	1.45	V		

ORDERING INFORMATION

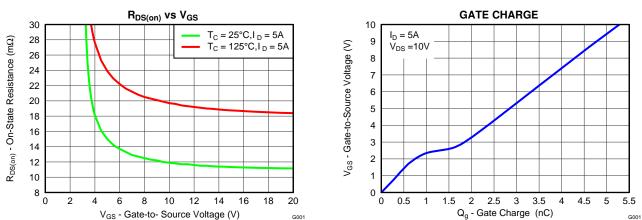
Device	Package	Media	Qty	Ship
CSD15571Q2	SON 2-mm × 2-mm Plastic Package	7-Inch Reel	3000	Tape and Reel

ABSOLUTE MAXIMUM RATINGS

T _A = 2	5°C unless otherwise stated	VALUE	UNIT
V_{DS}	Drain to Source Voltage	20	V
V_{GS}	Gate to Source Voltage	±20	V
	Continuous Drain Current (Package Limit)	22	А
ID	Continuous Drain Current ⁽¹⁾	10	А
I _{DM}	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	52	А
PD	Power Dissipation ⁽¹⁾	2.5	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	–55 to 150	°C
E _{AS}	Avalanche Energy, single pulse I_D = 19A, L = 0.1mH, R_G = 25 Ω	18	mJ

(1) $R_{\theta JA} = 50$ on $1in^2$ Cu (2 oz.) on .060" thick FR4 PCB.

(2) Pulse duration 10 μ s, duty cycle ≤2%



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

$T_A = 25^{\circ}C$, unless otherwise specified

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
Static Cl	haracteristics		· ·		
BV_{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	20		V
I _{DSS}	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = 20V$		1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = 20V$		100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	1.10 1.45	1.90	V
D	Durin to Course On Registeres	$V_{GS} = 4.5V, I_{DS} = 5A$	16.0	19.2	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V, I_{DS} = 5A$	12.0	15.0	mΩ
9 _{fs}	Transconductance	$V_{DS} = 16V, I_{DS} = 5A$	25		S
Dynamic	Characteristics		·		
C _{ISS}	Input Capacitance		320	419	pF
C _{OSS}	Output Capacitance	V _{GS} = 0V, V _{DS} = 10V, f = 1MHz	184	239	pF
C _{RSS}	Reverse Transfer Capacitance		32	42	pF
R _g	Series Gate Resistance		3.8	7.6	Ω
Qg	Gate Charge Total (4.5V)		2.5	3.3	nC
Qg	Gate Charge Total (10V)		5.1	6.7	nC
Q _{gd}	Gate Charge – Gate to Drain	$V_{DS} = 10V, I_{DS} = 5A$	0.66		nC
Q _{gs}	Gate Charge Gate to Source		0.93		nC
Q _{g(th)}	Gate Charge at Vth		0.52		nC
Q _{OSS}	Output Charge	$V_{DS} = 10V, V_{GS} = 0V$	4.1		nC
t _{d(on)}	Turn On Delay Time		4.7		ns
t _r	Rise Time	V _{DS} = 10V, V _{GS} = 4.5V, I _{DS} = 5A	17.2		ns
t _{d(off)}	Turn Off Delay Time	$R_{G} = 2\Omega$	9.9		ns
t _f	Fall Time		4.1		ns
Diode C	haracteristics		· · ·		
V_{SD}	Diode Forward Voltage	$I_{DS} = 5A, V_{GS} = 0V$	0.82	1	V
Q _{rr}	Reverse Recovery Charge		10.7		nC
t _{rr}	Reverse Recovery Time	$V_{DD} = 10V, I_F = 5A, di/dt = 300A/\mu s$	19		ns

THERMAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

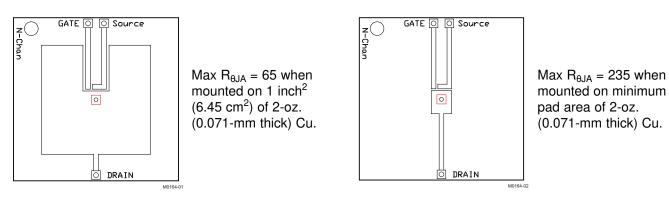
	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Thermal Resistance Junction to Case ⁽¹⁾			4.5	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ⁽¹⁾⁽²⁾			65	°C/W

(1) R_{eJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{eJC} is specified by design, whereas R_{eJA} is determined by the user's board design.
(2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.



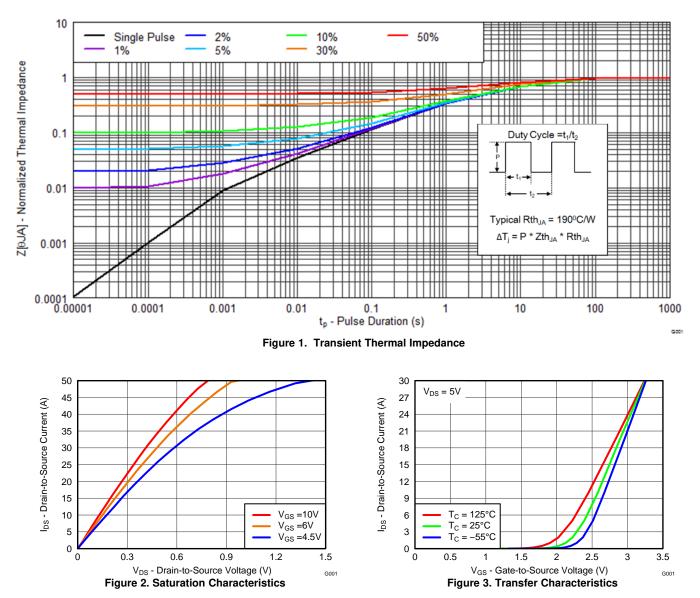
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TYPICAL MOSFET CHARACTERISTICS

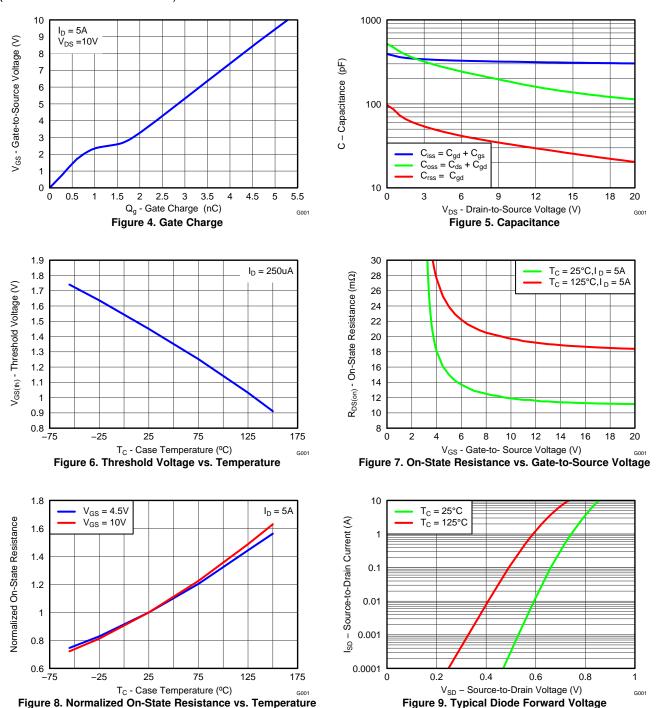
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



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TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



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TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

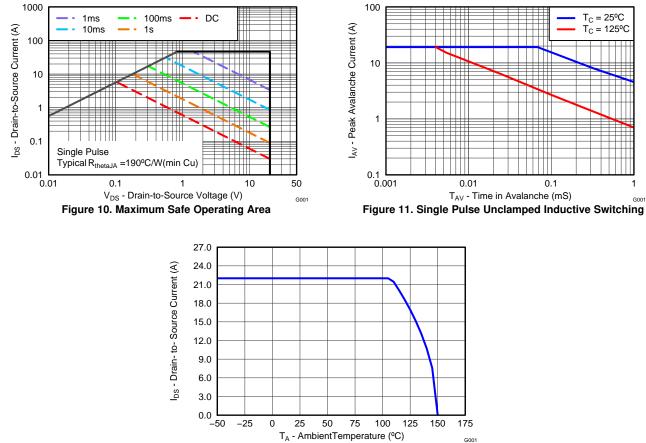


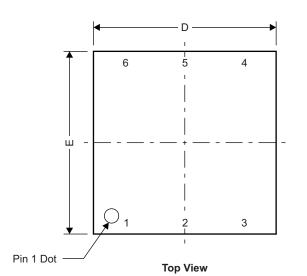
Figure 12. Maximum Drain Current vs. Temperature

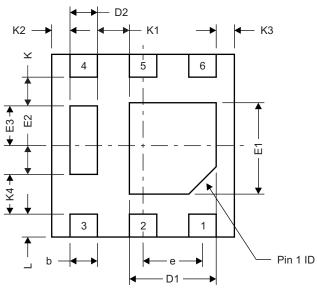
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MECHANICAL DATA

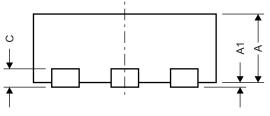
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Q2 Package Dimensions





Bottom View



Front View

M0165-01

DIM		MILLIMETERS			INCHES				
	MIN	NOM	МАХ	MIN	NOM	МАХ			
А	0.700	0.750	0.800	0.028	0.030	0.032			
A1	0.000		0.050	0.000		0.002			
b	0.250	0.300	0.350	0.010	0.012	0.014			
С		0.203 TYP			0.008 TYP				
D		2.000 TYP		0.080 TYP					
D1	0.900	0.950	1.000	0.036	0.038	0.040			
D2	0.300 TYP 0.012 TYP								
E		2.000 TYP		0.080 TYP					
E1	0.900	1.000	1.100	0.036	0.040	0.044			
E2		0.280 TYP			0.0112 TYP				
E3		0.470 TYP			0.0188 TYP				
е		0.650 BSC			0.026 TYP				
К		0.280 TYP			0.0112 TYP				
K1		0.350 TYP			0.014 TYP				
K2		0.200 TYP			0.008 TYP				
K3		0.200 TYP	0.008 TYP						
K4		0.470 TYP			0.0188 TYP				
L	0.200	0.25	0.300	0.008	0.010	0.012			

Submit Documentation Feedback

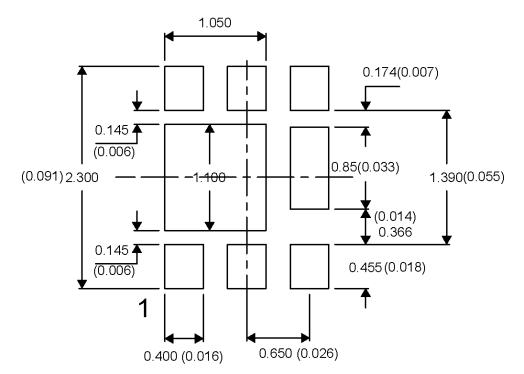
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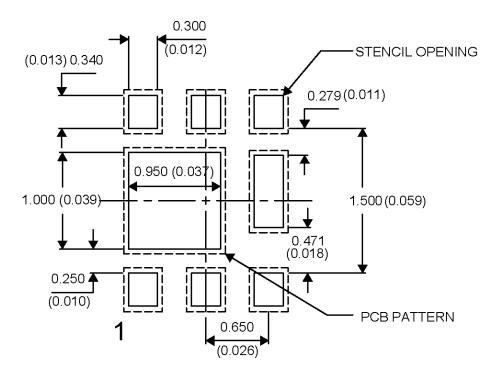
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Recommended PCB Pattern



For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

Recommended Stencil Pattern



Note: All dimensions are in mm, unless otherwise specified.

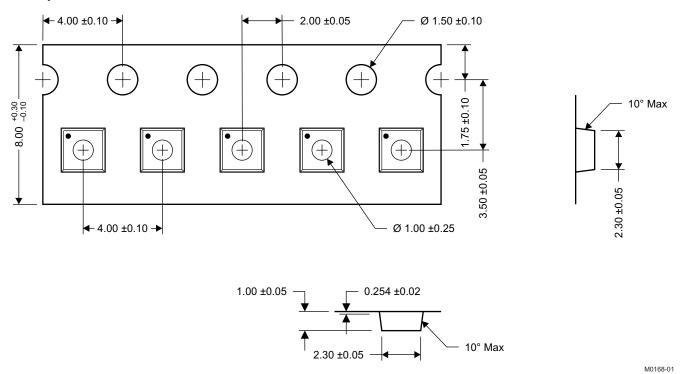
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NSTRUMENTS

FEXAS

Q2 Tape and Reel Information



Notes: 1. Measured from centerline of sprocket hole to centerline of pocket

- 2. Cumulative tolerance of 10 sprocket holes is ±0.20
- 3. Other material available
- 4. Typical SR of form tape Max 10⁹ OHM/SQ
- 5. All dimensions are in mm, unless otherwise specified.



10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD15571Q2	ACTIVE	WSON	DQK	6	3000	RoHS & Green	(6) NIPDAU SN	Level-1-260C-UNLIM	-55 to 150	1551	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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